

MM54HC153/MM74HC153 Dual 4-Input Multiplexer

General Description

This 4-to-1 line multiplexer utilizes advanced silicon-gate CMOS technology. It has the low power consumption and high noise immunity of standard CMOS integrated circuits. This device is fully buffered, allowing it to drive 10 LS-TTL loads. Information on the data inputs of each multiplexer is selected by the address on the A and B inputs, and is presented on the Y outputs. Each multiplexer possesses a strobe input which enables it when taken to a low logic level. When a high logic level is applied to a strobe input, the output of its associated multiplexer is taken low.

The 54HC/74HC logic family is functionally and pinout compatible with the standard 54LS/74LS logic family. All inputs

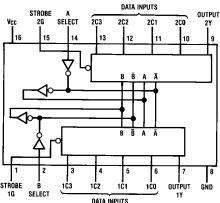
are protected from damage due to static discharge by internal diode clamps to V_{CC} and ground.

Features

- Typical propagation delay: 24 ns
- Wide power supply range: 2V-6V
- Low quiescent current: 80 µA maximum (74HC Series)
- Low input current: 1 μA maximum
- Fanout of 10 LS-TTL loads

Connection Diagram

Dual-In-Line Package



TL/F/5107-1

Order Number MM54HC153 or MM74HC153

Truth Table

Select Inputs			Data l	nputs	Strobe	Output	
В	Α	CO	C1	C2	C3	G	Υ
Х	Х	Х	Χ	Х	Χ	Н	L
L	L	L	Х	Х	Х	L	L
L	L	Н	Х	Х	Х	L	Н
L	Н	Х	L	Х	Х	L	L
L	Н	Х	Н	Х	Х	L	Н
Н	L	Х	Х	L	Х	L	L
Н	L	Х	Х	Н	Х	L	Н
Н	Н	X	Х	Х	L	L	L
Н	Н	Х	Х	Х	Н	L	Н

Select inputs A and B are common to both sections.

H = high level, L = low level, X = don't care.

Absolute Maximum Ratings (Notes 1 & 2)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage (V _{CC})	-0.5 to $+7.0$
DC Input Voltage (V _{IN})	-1.5 to $V_{CC} + 1.5$
DC Output Voltage (V _{OUT})	-0.5 to $V_{CC} + 0.5$
Clamp Diode Current (I _{IK} , I _{OK})	± 20 m/
DC Output Current, per pin (IOUT)	± 25 mA
DC V _{CC} or GND Current, per pin (I _{CC})	± 50 mA
Storage Temperature Range (T _{STG})	$-65^{\circ}\text{C to } + 150^{\circ}\text{C}$

Power Dissipation (PD)

(Note 3) 600 mW S.O. Package only 500 mW

Lead Temperature (T_L)
(Soldering 10 seconds

(Soldering 10 seconds) 260°C

Operating Conditions

Supply Voltage (V _{CC})	Min 2	Max 6	Units V
DC Input or Output Voltage (V_{IN}, V_{OUT})	0	V _{CC}	V
Operating Temp. Range (T _A) MM74HC MM54HC	-40 -55	+85 +125	°C
$ \begin{array}{ll} \text{Input Rise or Fall Times} \\ (t_{r},t_{f}) & V_{CC}\!=\!2.0V \\ & V_{CC}\!=\!4.5V \\ & V_{CC}\!=\!6.0V \end{array} $		1000 500 400	ns ns ns

DC Electrical Characteristics (Note 4)

Symbol	Parameter	Conditions	v _{cc}	T _A = 25°C		74HC T _A = -40 to 85°C	54HC T _A = -55 to 125°C	Units
				Тур		Guaranteed		
V _{IH}	Minimum High Level Input Voltage		2.0V 4.5V 6.0V		1.5 3.15 4.2	1.5 3.15 4.2	1.5 3.15 4.2	V V V
V _{IL}	Maximum Low Level Input Voltage**		2.0V 4.5V 6.0V		0.5 1.35 1.8	0.5 1.35 1.8	0.5 1.35 1.8	V V V
V _{OH}	Minimum High Level Output Voltage	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $ I_{OUT} \le 20 \mu A$	2.0V 4.5V 6.0V	2.0 4.5 6.0	1.9 4.4 5.9	1.9 4.4 5.9	1.9 4.4 5.9	V V V
		$V_{IN} = V_{IH} \text{ or } V_{IL}$ $ I_{OUT} \le 4.0 \text{ mA}$ $ I_{OUT} \le 5.2 \text{ mA}$	4.5V 6.0V	4.2 5.3	3.98 5.48	3.84 5.34	3.7 5.2	V V
V _{OL}	Maximum Low Level Output Voltage	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $ I_{OUT} \le 20 \mu A$	2.0V 4.5V 6.0V	0 0 0	0.1 0.1 0.1	0.1 0.1 0.1	0.1 0.1 0.1	V V V
		$V_{IN} = V_{IH} \text{ or } V_{IL}$ $ I_{OUT} \le 4.0 \text{ mA}$ $ I_{OUT} \le 5.2 \text{ mA}$	4.5V 6.0V	0.2 0.2	0.26 0.26	0.33 0.33	0.4 0.4	V V
I _{IN}	Maximum Input Current	V _{IN} =V _{CC} or GND	6.0V		±0.1	±1.0	±1.0	μΑ
Icc	Maximum Quiescent Supply Current	$V_{IN} = V_{CC}$ or GND $I_{OUT} = 0 \mu A$	6.0V		8.0	80	160	μΑ

Note 1: Absolute Maximum Ratings are those values beyond which damage to the device may occur.

Note 3: Power Dissipation temperature derating — plastic "N" package: -12 mW/°C from 65°C to 85°C; ceramic "J" package: -12 mW/°C from 100°C to 125°C.

Note 4: For a power supply of 5V \pm 10% the worst case output voltages (V_{OH}, and V_{OL}) occur for HC at 4.5V. Thus the 4.5V values should be used when designing with this supply. Worst case V_{IH} and V_{IL} occur at V_{CC}=5.5V and 4.5V respectively. (The V_{IH} value at 5.5V is 3.85V.) The worst case leakage current (I_{IN}, I_{CC}, and I_{OZ}) occur for CMOS at the higher voltage and so the 6.0V values should be used.

Note 2: Unless otherwise specified all voltages are referenced to ground.

^{**}V_{IL} limits are currently tested at 20% of V_{CC}. The above V_{IL} specification (30% of V_{CC}) will be implemented no later than Q1, CY'89.

AC Electrical Characteristics V_{CC}=5V, T_A=25°C, C_L=15 pF, t_r=t_f=6 ns

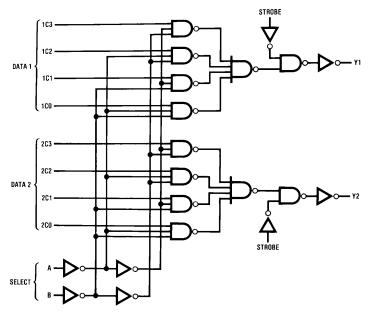
Symbol	Parameter	Conditions	Тур	Guaranteed Limit	Units
t _{PHL} , t _{PLH}	Maximum Propagation Delay, Select A or B to Y		26	30	ns
t _{PHL} , t _{PLH}	Maximum Propagation Delay, any Data to Y		20	23	ns
t _{PHL} , t _{PLH}	Maximum Propagation Delay, Strobe to Y		8	15	ns

AC Electrical Characteristics $C_L = 50 \text{ pF}, t_r = t_f = 6 \text{ ns}$ (unless otherwise specified)

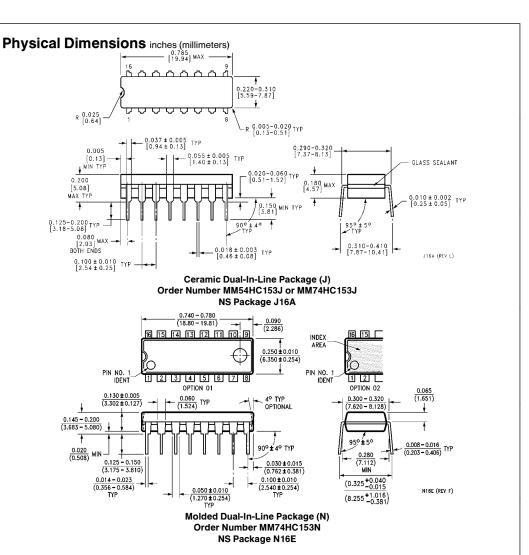
Symbol	Parameter	Conditions	v _{cc}	T _A =25°C		74HC T _A = -40 to 85°C	54HC T _A = -55 to 125°C	Units
				Тур		Guarantee	Guaranteed Limits	
t _{PHL} , t _{PLH}	Maximum Propagation Delay, Select A or B to Y		2.0V 4.5V 6.0V	131 29 25	158 35 30	198 44 38	237 52 45	ns ns ns
t _{PHL} , t _{PLH}	Maximum Propagation Delay, any Data to Y		2.0V 4.5V 6.0V	99 22 19	126 28 23	158 35 29	189 42 35	ns ns ns
t _{PHL} , t _{PLH}	Maximum Propagation Delay, Strobe to Y		2.0V 4.5V 6.0V	50 12 10	86 19 16	108 24 20	129 29 24	ns ns ns
t _{TLH} , t _{THL}	Maximum Output Rise and Fall Time		2.0V 4.5V 6.0V	30 8 7	75 15 13	95 19 16	110 22 19	ns ns ns
C _{IN}	Maximum Input Capacitance			5	10	10	10	pF
C _{PD}	Power Dissipation Capacitance	(Note 5)(per package) Outputs Enabled Outputs Disabled		90 25				pF pF

Note 5: C_{PD} determines the no load dynamic power consumption, $P_D = C_{PD} \ V_{CC}^2 \ f + I_{CC} \ V_{CC}$, and the no load dynamic current consumption, $I_S = C_{PD} \ V_{CC} \ f + I_{CC}$

Logic Diagram



TL/F/5107-2



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National Semiconductor

National Semiconducto Corporation 1111 West Bardin Road Arlington, TX 76017 Tel: 1(800) 272-9959 Fax: 1(800) 737-7018

National Semiconductor Europe

Fax: (+49) 0-180-530 85 86 Fax: (+49) U-18U-35U oo oo Email: onjwege tevm2.nsc.com Deutsch Tel: (+49) 0-180-530 85 85 English Tei: (+49) 0-180-532 78 32 Français Tei: (+49) 0-180-532 93 58 Italiano Tel: (+49) 0-180-534 16 80

National Semiconductor Hong Kong Ltd.
13th Floor, Straight Block,
Ocean Centre, 5 Canton Rd. Tsimshatsui, Kowloon

Hong Kong Tel: (852) 2737-1600 Fax: (852) 2736-9960

National Semiconductor Japan Ltd.
Tel: 81-043-299-2309
Fax: 81-043-299-2408